Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/531,005	CHOI ET AL.	
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED					
Class	Subclass	Date	Examiner		
715	827	11/2/2005	LVN		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	o: 345/172; /827	11/2/2005			

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	DATE	EXMR
USPG-Pub; USPAT: 715/716- 720,711,783,810,834- 838,840,847,805,825,826; 348/14.05,14.03	11/2/2005	LVN